

Svenska Elektriska Kommissionen, SEK

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Elektromagnetisk kompatibilitet (EMC) – Del 4-29: Mät- och provningsmetoder – Provning av immunitet mot kortvariga spänningssänknings, spänningsavbrott och spänningsvariationer vid likströmsmatning

*Electromagnetic compatibility (EMC) –
Part 4-29: Testing and measurement techniques –
Voltage dips, short interruptions and voltage variations on d.c.
input power port immunity tests*

Som svensk standard gäller europastandarden EN 61000-4-29:2000. Den svenska standarden innehåller den officiella engelska språkversionen av EN 61000-4-29:2000.

Nationellt förord

Europastandarden EN 61000-4-29:2000

består av:

- **europastandardens ikraftsättningsdokument**, utarbetat inom CENELEC
- **IEC 61000-4-29, First edition, 2000 - Electromagnetic compatibility (EMC) - Part 4-29: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests**

utarbetad inom International Electrotechnical Commission, IEC.

Electromagnetic compatibility (EMC)
Part 4-29: Testing and measurement techniques -
Voltage dips, short interruptions and voltage variations
on d.c. input power port immunity tests
(IEC 61000-4-29:2000)

Compatibilité électromagnétique (CEM)
Partie 4-29: Techniques d'essai et de
mesure -
Essais d'immunité aux creux de tension,
coupures brèves et variations de tension
sur les accès d'alimentation en courant
continu
(CEI 61000-4-29:2000)

Elektromagnetische Verträglichkeit (EMV)
Teil 4-29: Prüf- und Messverfahren -
Prüfungen der Störfestigkeit gegen
Spannungseinbrüche,
Kurzzeitunterbrechungen und
Spannungsschwankungen an
Gleichstrom-Netzeingängen
(IEC 61000-4-29:2000)

This European Standard was approved by CENELEC on 2000-11-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Czech Republic, Denmark, Finland, France, Germany, Greece, Iceland, Ireland, Italy, Luxembourg, Netherlands, Norway, Portugal, Spain, Sweden, Switzerland and United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

Foreword

The text of document 77A/307/FDIS, future edition 1 of IEC 61000-4-29, prepared by SC 77A, Low-frequency phenomena, of IEC TC 77, Electromagnetic compatibility, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61000-4-29 on 2000-11-01.

The following dates were fixed:

- latest date by which the EN has to be implemented
at national level by publication of an identical
national standard or by endorsement (dop) 2001-08-01
- latest date by which the national standards conflicting
with the EN have to be withdrawn (dow) 2003-11-01

Annexes designated "normative" are part of the body of the standard.
Annexes designated "informative" are given for information only.
In this standard, annexes B and ZA are normative and annex A is informative.
Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61000-4-29:2000 was approved by CENELEC as a European Standard without any modification.

Annex ZA
(normative)

**Normative references to international publications
with their corresponding European publications**

This European Standard incorporates by dated or undated reference, provisions from other publications. These normative references are cited at the appropriate places in the text and the publications are listed hereafter. For dated references, subsequent amendments to or revisions of any of these publications apply to this European Standard only when incorporated in it by amendment or revision. For undated references the latest edition of the publication referred to applies (including amendments).

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60050-161	1990	International Electrotechnical Vocabulary (IEV) - Chapter 161: Electromagnetic compatibility	-	-
IEC 61000-4-11	1994	Electromagnetic compatibility (EMC) Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests	EN 61000-4-11	1994

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ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-29: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests

1 Scope and object

This part of IEC 61000 defines test methods for immunity to voltage dips, short interruptions and voltage variations at the d.c. input power port of electrical or electronic equipment.

This standard is applicable to low voltage d.c. power ports of equipment supplied by external d.c. networks.

The object of this standard is to establish a common and reproducible basis for testing electrical and electronic equipment when subjected to voltage dips, short interruptions or voltage variations on d.c. input power ports.

This standard defines:

- the range of test levels;
- the test generator;
- the test set-up;
- the test procedure.

The test described hereinafter applies to electrical and electronic equipment and systems. It also applies to modules or subsystems whenever the EUT (equipment under test) rated power is greater than the test generator capacity specified in clause 6.

The ripple at the d.c. input power port is not included in the scope of this part of IEC 61000. It is covered by IEC 61000-4-17¹⁾

This standard does not specify the tests to be applied to particular apparatus or systems. Its main aim is to give a general basic reference to IEC product committees. These product committees (or users and manufacturers of equipment) remain responsible for the appropriate choice of the tests and the severity level to be applied to their equipment.

¹⁾ IEC 61000-4-17, *Electromagnetic compatibility (EMC) – Part 4-17: Testing and measurement techniques – Ripple on d.c. input power port immunity test*